INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Application Number	10629301
Filing Date	2003-07-28
First Named Inventor	Lewis B. Aronson
Art Unit	2613
Examiner Name	Hanh Phan
Attorney Docket Number	15436.247.2.1.3

	U.S. PATENTS					
Examiner Initials*	Cite No.	Patent Number	Issue Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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/HP/	2	6977517	2005-12-20	Miao et al		
/HP/	3	7019548	2006-03-28	Miao et al		
/HP/	4	7155127	2006-12-26	Akimoto		
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Examiner Initials*	Cite No.	Publication Number	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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Examiner Initials*	Cite No.	Application Number	Mail Date	Document			
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	NON PATENT LITERATURE DOCUMENTS						
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published	T 1				
/HP/	1	HAWTHORNE: "850nm Proton VCSEL Reliability Study" Technical Publications and Application Notes, Advances Optical Components (Finisar Corp), Issue 2, September 2001, pgs 1-7, Richardson, TX					
/HP/	2	MECHERLE G S ET AL: "Considerations for Accelerated Laser Diode Life Testing" Proceedings of the Spie, Spie, Bellingham, VA, vol. 717, 1986, pgs 53-62					
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Examiner Initials*	Cite No.	Application Number	Mail Date	Document		
/HP/	1	11118172	2008-09-04	Office Action		
/HP/	2	10629302	2008-01-25	Restriction Requirement		
/HP/	3	11073452	2008-08-07	Office Action		
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/HP/	5	11073452	2007-12-31	Office Action		
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/HP/	7	10884334	2008-01-16	Office Action		
/HP/	8	10884334	2008-07-10	Office Action		

EXAMINER SIGNATURE				
/Hanh Phan/	Date Considered	03/15/2009		

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